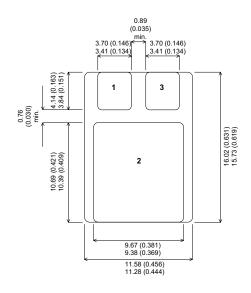
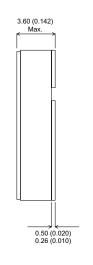




#### **MECHANICAL DATA**

Dimensions in mm (inches)





### SMD<sub>1</sub>

Pad 1 - Gate

Pad 2 - Drain

Pad 3 - Source

## **P-CHANNEL POWER MOSFET** FOR HI-REL **APPLICATIONS**

 $V_{DSS}$ -100V I<sub>D(cont)</sub> -8A R<sub>DS(on)</sub>  $0.35\Omega$ 

### **FEATURES**

- HERMETICALLY SEALED
- SIMPLE DRIVE REQUIREMENTS
- LIGHTWEIGHT
- SCREENING OPTIONS AVAILABLE
- ALL LEADS ISOLATED FROM CASE

# **ABSOLUTE MAXIMUM RATINGS** (T<sub>case</sub> = 25°C unless otherwise stated)

$V_{GS}$	Gate – Source Voltage	±20V
$I_{D}$	Continuous Drain Current @ T <sub>case</sub> = 25°C	8A
$I_{D}$	Continuous Drain Current @ T <sub>case</sub> = 100°C	5A
$I_{DM}$	Pulsed Drain Current	40A
$P_{D}$	Power Dissipation @ T <sub>case</sub> = 25°C	45W
	Linear Derating Factor	0.36W/°C
$T_J$ , $T_stg$	Operating and Storage Temperature Range	−55 to 150°C
$R_{\theta JC}$	Thermal Resistance Junction to Case	2.8°C/W max.





### **ELECTRICAL CHARACTERISTICS** ( $T_C = 25$ °C unless otherwise stated)

	Parameter	Test Conditions	Min.	Тур.	Max.	Unit	
	STATIC ELECTRICAL RATINGS			·			
BV <sub>DSS</sub>	Drain – Source Breakdown Voltage	$V_{GS} = 0$ $I_D = 1mA$	100			V	
$\Delta BV_{DSS}$	Temperature Coefficient of	Reference to 25°C		0.1		V/°C	
$\Delta T_{J}$	Breakdown Voltage	I <sub>D</sub> = 1mA		0.1			
R <sub>DS(on)</sub>	Static Drain – Source On–State	$V_{GS} = 10V$ $I_D = 5A$			0.35	Ω	
	Resistance	$V_{GS} = 10V$ $I_D = 8A$			0.4		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ $I_D = 250\mu A$	2		4	V	
9 <sub>fs</sub>	Forward Transconductance	$V_{DS} \ge 15V$ $I_{DS} = 5A$	3			S(\O)	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{GS} = 0$ $V_{DS} = 0.8BV_{DSS}$			25	^	
		T <sub>J</sub> = 125°C			250	<del> </del> μΑ	
I <sub>GSS</sub>	Forward Gate – Source Leakage	V <sub>GS</sub> = 20V			100	- ^	
I <sub>GSS</sub>	Reverse Gate – Source Leakage	V <sub>GS</sub> = -20V			-100	nA	
	DYNAMIC CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0		860		pF	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V		350			
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1MHz		125			
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> = 10V I <sub>D</sub> = 8A	12.5		29	nC	
g	Total Cate Charge	$V_{DS} = 0.5BV_{DSS}$	12.0				
$Q_{gs}$	Gate - Source Charge	I <sub>D</sub> = 8A	1.0		6.3	nC	
$Q_{gd}$	Gate - Drain ("Miller") Charge	$V_{DS} = 0.5BV_{DSS}$	2		27		
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 50V			60	ns	
t <sub>r</sub>	Rise Time				140		
t <sub>d(off)</sub>	Turn-Off Delay Time				140		
t <sub>f</sub>	Fall Time	$R_G = 7.5\Omega$			140		
	SOURCE - DRAIN DIODE CHARAC	TERISTICS					
I <sub>S</sub>	Continuous Source Current				8	A	
I <sub>SM</sub>	Pulse Source Current				32		
V <sub>SD</sub>	Diode Forward Voltage	$I_S = 8A$ $T_J = 25$ °C $V_{GS} = 0$			4.7	V	
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> = 8A T <sub>J</sub> = 25°C			300	ns	
Q <sub>rr</sub>	Reverse Recovery Charge	d <sub>i</sub> / d <sub>t</sub> ≤ 100A/μs V <sub>DD</sub> ≤ 50V			3	μС	
	PACKAGE CHARACTERISTICS						
L <sub>D</sub>		rom 6mm down drain lead pad to centre of die)		8.7			
L <sub>S</sub>	Internal Source Inductance (from 6mm do	down source lead to centre of source bond pad) 8				⊢ nH	